	 lotes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/044,195	SYED, MAJID
Examiner	Art Unit
Thuong T. Nguyen	2155

SEARCHED			
Class	Subclass	Date	Examiner
709	226,225, 231	9/6/2005	тн
725	63,73, 86	6/5/2005	ТН
348	6,7,384	9/6/2005	ТН
370	326,477	9/6/2005	TH

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
-			

SEA (INCLUDING	RCH NOTES)
		DATE	EXMR
IEEE		9/6/2005	тн
EAST		9/6/2005	тн